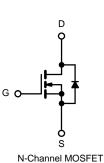


## D2816-VB Datasheet N-Channel 80 V (D-S) MOSFET

| PRODUCT SUMMARY                   |   |  |  |  |
|-----------------------------------|---|--|--|--|
| $R_{DS(on)}$ ( $\Omega$ ) Max.    | I <sub>D</sub> (A)  | Q <sub>g</sub> (Typ.)  |  |  |
| 0.0050 at $V_{GS} = 10 V$         | 75 <sup>a</sup>   |  |  |  |
| 0.0070 at V <sub>GS</sub> = 6.0 V | 65 <sup>a</sup>   | 17.1 nC  |  |  |
| 0.0087 at V <sub>GS</sub> = 5.0 V | 54  |  |  |  |
|                                   | R <sub>DS(on)</sub> (Ω) Max.<br>0.0050 at V <sub>GS</sub> = 10 V<br>0.0070 at V <sub>GS</sub> = 6.0 V | $\mathbf{R}_{DS(on)}$ (Ω) Max. $\mathbf{I}_{D}$ (A)   0.0050 at $V_{GS}$ = 10 V 75 <sup>a</sup> 0.0070 at $V_{GS}$ = 6.0 V 65 <sup>a</sup> |  |  |

# 



Top View

#### FEATURES

- Trench Power MOSFET
- + 100 %  $\rm R_g$  and UIS Tested

#### **APPLICATIONS**

- Primary Side Switching
- Synchronous Rectification
- DC/AC Inverters
- LED Backlighting



| ABSOLUTE MAXIMUM RATINGS (7                                  | √ <sub>A</sub> = 25 °C, unless | otherwise noted                   | d)                   |     |
|--|--------------------------------|-----------------------------------|----------------------|-----|
| Parameter  | Symbol                         | Limit                             | Unit                 |     |
| Drain-Source Voltage   | V <sub>DS</sub>                | 80                                | V                    |     |
| Gate-Source Voltage  |                                | V <sub>GS</sub>                   | ± 20                 | v   |
|  | T <sub>C</sub> = 25 °C         |                                   | 75 <sup>a</sup>      |     |
| Continuous Drain Current (T. 150 °C)                         | T <sub>C</sub> = 70 °C         |                                   | 62.7                 |     |
| Continuous Drain Current ( $T_J = 150 \ ^{\circ}C$ )         | T <sub>A</sub> = 25 °C         | I <sub>D</sub>                    | 28.6 <sup>b, c</sup> |     |
|  | T <sub>A</sub> = 70 °C         |                                   | 24.9 <sup>b, c</sup> | •   |
| Pulsed Drain Current (t = 100 µs)                            | I <sub>DM</sub>                | 150                               | — A                  |     |
| Continuous Sources Drain Diado Current                       | T <sub>C</sub> = 25 °C         | 1                                 | 75a                  |     |
| Continuous Source-Drain Diode Current                        | T <sub>A</sub> = 25 °C         | I <sub>S</sub>                    | 4.5 <sup>b, c</sup>  |     |
| Single Pulse Avalanche Current                               | 1 0.1 mll                      | I <sub>AS</sub>                   | 30                   |     |
| Single Pulse Avalanche Energy                                | L = 0.1 mH                     | E <sub>AS</sub>                   | 45                   | mJ  |
| Maximum Power Dissipation                                    | T <sub>C</sub> = 25 °C         |                                   | 62.5                 |     |
|  | T <sub>C</sub> = 70 °C         | <b>D</b>                          | 40                   | 10/ |
|  | T <sub>A</sub> = 25 °C         | P <sub>D</sub>                    | 5 <sup>b, c</sup>    | W   |
|  | T <sub>A</sub> = 70 °C         |                                   | 3.2 <sup>b, c</sup>  |     |
| Operating Junction and Storage Temperature Range             |                                | T <sub>J</sub> , T <sub>stg</sub> | - 55 to 150          | *0  |
| Soldering Recommendations (Peak Temperature) <sup>d, e</sup> |                                |                                   | 260                  |     |

| THERMAL RESISTANCE RATINGS                  |              |                   |         |         |      |
|---|--------------|-------------------|---------|---------|------|
| Parameter                                   |              | Symbol            | Typical | Maximum | Unit |
| Maximum Junction-to-Ambient <sup>b, f</sup> | t ≤ 10 s     | R <sub>thJA</sub> | 20      | 25      | °C/W |
| Maximum Junction-to-Case (Drain)            | Steady State | R <sub>thJC</sub> | 1.5     | 2.0     | C/ W |

#### Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

- d. The TO-220 is a leadless package. The end of the lead terminal is exposed
- copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 70 °C/W.

| Parameter                                     | Symbol                  | Test Conditions  | Min. | Тур.   | Max.  | Unit     |  |
|---|-------------------------|--|------|--------|-------|----------|--|
| Static  | <u> </u>                |  |      |        |       | <b>I</b> |  |
| Drain-Source Breakdown Voltage                | V <sub>DS</sub>         | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA   | 80   |        |       | V        |  |
| V <sub>DS</sub> Temperature Coefficient       | $\Delta V_{DS}/T_J$     |  |      | 37     |       |          |  |
| V <sub>GS(th)</sub> Temperature Coefficient   | $\Delta V_{GS(th)}/T_J$ | I <sub>D</sub> = 250 μΑ  |      | - 6.1  |       | mV/°C    |  |
| Gate-Source Threshold Voltage                 | V <sub>GS(th</sub> )    | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA                              | 2.5  |        | 4.0   | V        |  |
| Gate-Source Leakage                           | I <sub>GSS</sub>        | $V_{DS} = 0 V, V_{GS} = \pm 20 V$  |      |        | ± 100 | nA       |  |
|   |                         | $V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$  |      |        | 1     | μA       |  |
| Zero Gate Voltage Drain Current               | IDSS                    | V <sub>DS</sub> = 80 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C                    |      |        | 10    |          |  |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>      | $V_{DS} \ge 5 V, V_{GS} = 10 V$  | 30   |        |       | А        |  |
|   |                         | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A  |      | 0.0050 |       |          |  |
| Drain-Source On-State Resistance <sup>a</sup> | R <sub>DS(on)</sub>     | V <sub>GS</sub> = 6 V, I <sub>D</sub> = 15 A   |      | 0.0070 |       | Ω        |  |
|   |                         | $V_{GS} = 5.0 \text{ V}, \text{ I}_{D} = 10 \text{ A}$                                   |      | 0.0087 |       | 1        |  |
| Forward Transconductance <sup>a</sup>         | g <sub>fs</sub>         | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 20 A  |      | 60     |       | S        |  |
| Dynamic <sup>b</sup>                          |                         |  |      |        |       | •        |  |
| Input Capacitance                             | C <sub>iss</sub>        |  |      | 1855   |       |          |  |
| Output Capacitance                            | C <sub>oss</sub>        | V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V, f = 1 MHz                                 |      | 950    |       | pF       |  |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>        |  |      | 76     |       |          |  |
|   |                         | $V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$                     |      | 35.5   | 54    |          |  |
| Total Gate Charge                             | Qg                      | $V_{DS} = 40 \text{ V}, V_{GS} = 6 \text{ V}, I_D = 10 \text{ A}$                        | 22   |        | 33    | 1        |  |
|   |                         |  |      | 17.1   | 26    | nC       |  |
| Gate-Source Charge                            | Q <sub>gs</sub>         | $V_{DS} = 40 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$                    |      | 5.3    |       |          |  |
| Gate-Drain Charge                             | Q <sub>gd</sub>         |  |      | 7.3    |       |          |  |
| Output Charge                                 | Q <sub>oss</sub>        | $V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$                                    |      | 57     | 86    |          |  |
| Gate Resistance                               | R <sub>g</sub>          | f = 1 MHz  | 0.5  | 1.3    | 2     | Ω        |  |
| Turn-On Delay Time                            | t <sub>d(on)</sub>      |  |      | 12     | 24    |          |  |
| Rise Time                                     | t <sub>r</sub>          | $V_{DD} = 40 \text{ V}, \text{ R}_{\text{I}} = 4 \Omega$                                 |      | 8      | 16    |          |  |
| Turn-Off DelayTime                            | t <sub>d(off)</sub>     | $I_D \cong 10$ Å, $V_{GEN} = 10$ V, $R_g = 1$ $\Omega$                                   |      | 32     | 64    |          |  |
| Fall Time                                     | t <sub>f</sub>          |  |      | 7      | 14    | 1        |  |
| Turn-On Delay Time                            | t <sub>d(on)</sub>      |  |      | 14     | 28    | ns       |  |
| Rise Time                                     | t <sub>r</sub>          | $V_{DD} = 40 \text{ V}, \text{ R}_{\text{I}} = 4 \Omega$                                 |      | 11     | 22    | 1        |  |
| Turn-Off DelayTime                            | t <sub>d(off)</sub>     | $I_D \cong 10$ Å, $V_{GEN} = 6.0$ V, $R_g = 1$ $\Omega$                                  |      | 30     | 60    | 1        |  |
| Fall Time                                     | t <sub>f</sub>          |  |      | 8      | 16    |          |  |
| Drain-Source Body Diode Characteristic        | s                       |  |      |        |       | •        |  |
| Continuous Source-Drain Diode Current         | ا <sub>S</sub>          | T <sub>C</sub> = 25 °C   |      |        | 75    | _        |  |
| Pulse Diode Forward Current (t = 100 µs)      | I <sub>SM</sub>         |  |      |        | 150   | A        |  |
| Body Diode Voltage                            | V <sub>SD</sub>         | I <sub>S</sub> = 5 A   |      | 0.76   | 1.1   | V        |  |
| Body Diode Reverse Recovery Time              | t <sub>rr</sub>         |  |      | 38     | 75    | ns       |  |
| Body Diode Reverse Recovery Charge            | Q <sub>rr</sub>         |  |      | 36     | 70    | nC       |  |
| Reverse Recovery Fall Time                    | ta                      | $I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^\circ\text{C}$ |      | 19     |       |          |  |
| Reverse Recovery Rise Time                    | t <sub>b</sub>          |  |      | 19     |       | ns       |  |

#### Notes

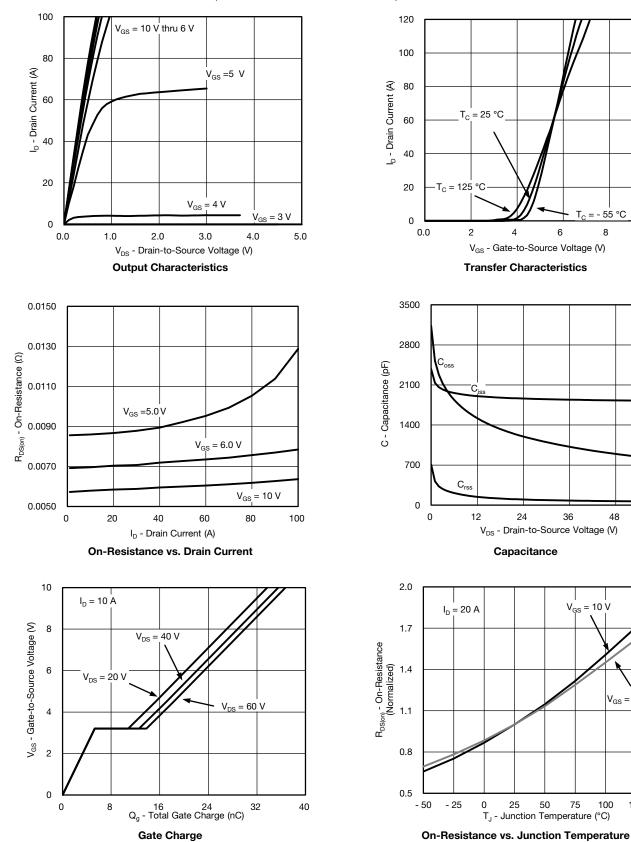
a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

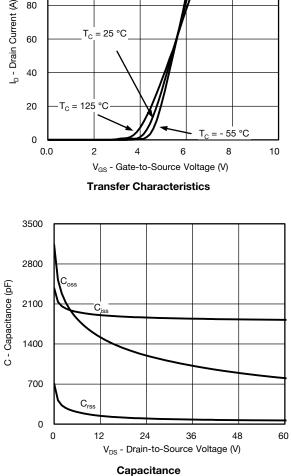
b. Guaranteed by design, not subject to production testing.

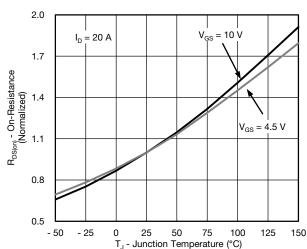
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Bsemi



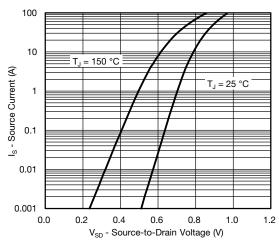




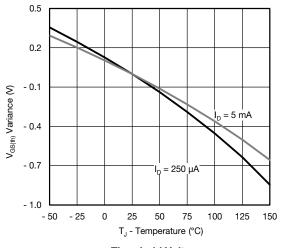


3

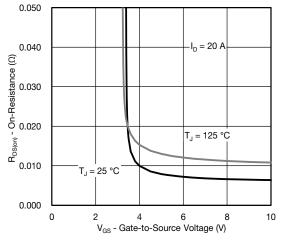




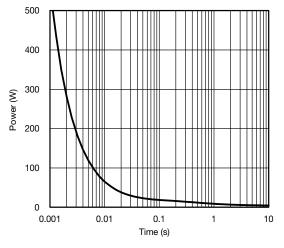




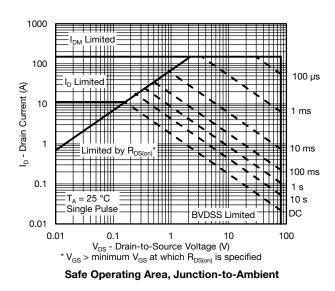




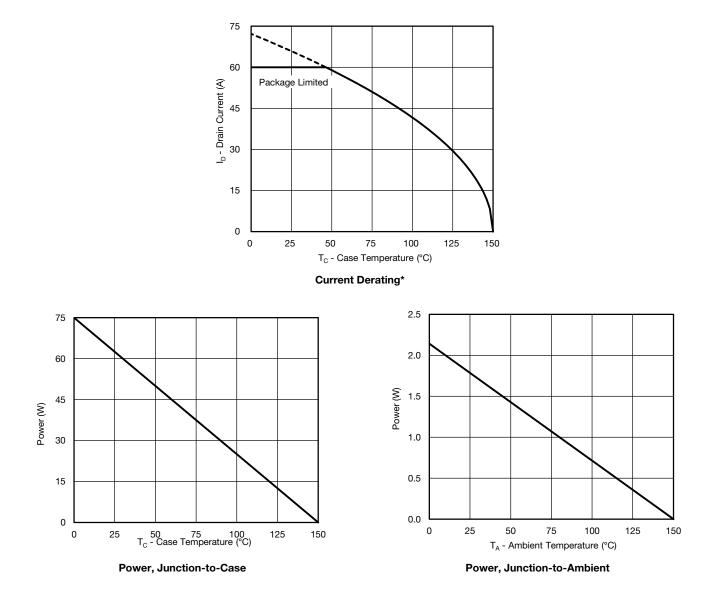
**On-Resistance vs. Gate-to-Source Voltage** 



Single Pulse Power, Junction-to-Ambient

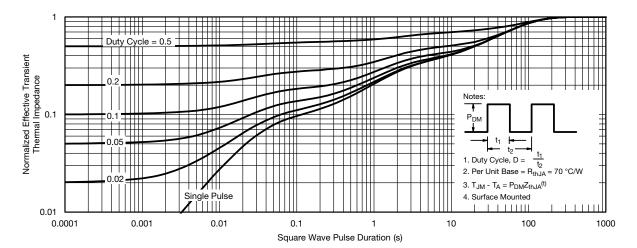




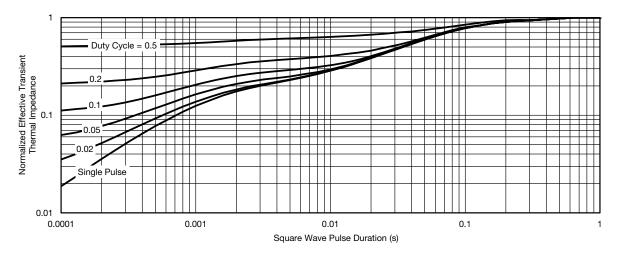


\* The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





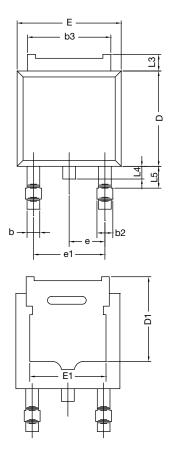


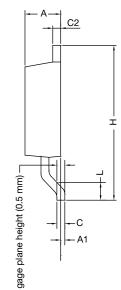


Normalized Thermal Transient Impedance, Junction-to-Case



# **TO-252AA CASE OUTLINE**





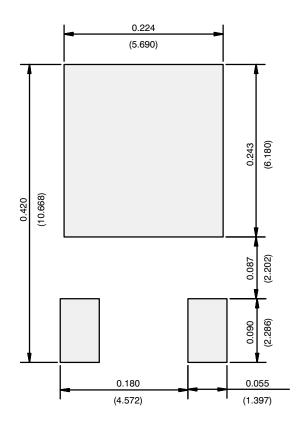
|  | MILLIMETERS |            | INC   | HES   |  |
|--|-------------|------------|-------|-------|--|
| DIM.   | MIN.        | MAX.       | MIN.  | MAX.  |  |
| А  | 2.18        | 2.38       | 0.086 | 0.094 |  |
| A1   | -           | 0.127      | -     | 0.005 |  |
| b  | 0.64        | 0.88       | 0.025 | 0.035 |  |
| b2   | 0.76        | 1.14       | 0.030 | 0.045 |  |
| b3   | 4.95        | 5.46       | 0.195 | 0.215 |  |
| С  | 0.46        | 0.61       | 0.018 | 0.024 |  |
| C2   | 0.46        | 0.89       | 0.018 | 0.035 |  |
| D  | 5.97        | 6.22       | 0.235 | 0.245 |  |
| D1   | 5.21        | -          | 0.205 | -     |  |
| Е  | 6.35        | 6.73       | 0.250 | 0.265 |  |
| E1   | 4.32        | -          | 0.170 | -     |  |
| Н  | 9.40        | 10.41      | 0.370 | 0.410 |  |
| е  | 2.28        | 8 BSC 0.09 |       | 0 BSC |  |
| e1   | 4.56 BSC    |            | 0.180 | BSC   |  |
| L  | 1.40        | 1.78       | 0.055 | 0.070 |  |
| L3   | 0.89        | 1.27       | 0.035 | 0.050 |  |
| L4   | -           | 1.02       | -     | 0.040 |  |
| L5   | 1.14        | 1.52       | 0.045 | 0.060 |  |
| ECN: X12-0247-Rev. M, 24-Dec-12<br>DWG: 5347 |             |            |       |       |  |

#### Note

• Dimension L3 is for reference only.



### **RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)**



Recommended Minimum Pads Dimensions in Inches/(mm)



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